Search Notes



Application/Control No.	Applicant(s)/Patent Unde
	Reexamination

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Examiner Art Unit

SEARCHED

Miah, Liton

Class	Subclass	Date	Examiner
370	329	9/25/2007	Liton Miah
370	331	9/25/2007	Liton Miah
370	235	9/25/2007	Liton Miah
714	707	9/25/2007	Liton Miah
714	708	9/25/2007	Liton Miah
714	704	9/25/2007	Liton Miah
Search	Updated	3/18/2008	Liton Miah
Search	Updated	6/19/2008	Liton Miah

SEARCH NOTES

Search Notes	Date	Examiner
EAST (US-PGPUB; USPAT; FPRS; EPO; JPO; DERWENT; IBM_TDB)	9/25/2007	Liton Miah
Consulted with Spe (Rafael Gutierrez-Perez)	9/25/2007	Liton Miah
Inventorship Search	9/25/2007	Liton Miah
Search Updated	3/18/2008	Liton Miah
Search Updated	6/19/2008	Liton Miah

INTERFERENCE SEARCH

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